

2450 SourceMeter® SMU Instrument

Datasheet



KEITHLEY
A Tektronix Company

The 2450 is Keithley's next-generation SourceMeter source measure unit (SMU) instrument that truly brings Ohm's law (current, voltage, and resistance) testing right to your fingertips. Its innovative graphical user interface (GUI) and advanced, capacitive touchscreen technology allow intuitive usage and minimize the learning curve to enable engineers and scientists to learn faster, work smarter, and invent easier. The 2450 is the SMU for everyone: a versatile instrument, particularly well-suited for characterizing modern scaled semiconductors, nano-scale devices and materials, organic semiconductors, printed electronics, and other small-geometry and low-power devices. All this combined with Keithley SMU precision and accuracy allows users to Touch, Test, Invent® with the new favorite go-to instrument in the lab for years to come.

Key Features

- Capabilities of analyzers, curve tracers, and I-V systems at a fraction of their cost
- Five-inch, high resolution capacitive touchscreen GUI
- 0.012% basic measure accuracy with 6½-digit resolution
- Enhanced sensitivity with new 20mV and 10nA source/measure ranges
- Source and sink (four-quadrant) operation
- Four "Quickset" modes for fast setup and measurements
- Built-in, context-sensitive front panel help
- Front panel input banana jacks; rear panel input triaxial connections
- 2450 SCPI and TSP® scripting programming modes
- 2400 SCPI-compatible programming mode
- Front panel USB memory port for storing data, programming, instrument configurations, and to upgrade the unit



2450 main home screen.

Learn Faster, Work Smarter, and Invent Easier

Unlike conventional instruments with dedicated push-button technology and small, obscure, limited-character displays, the 2450 features a five-inch, full-color, high-resolution touchscreen that facilitates ease of use, learning, and optimizes overall speed and productivity. A simple icon-based menu structure reduces configuration steps by as much as 50 percent and eliminates the cumbersome multi-layer menu structures typically used on soft-key instruments. Built-in, context-sensitive help enables intuitive operation and minimizes the need to review a separate manual. These capabilities combined with its application versatility make the 2450 the SMU instrument inherently easy to use for basic and advanced measurement applications, regardless of your experience level with SMU instruments.

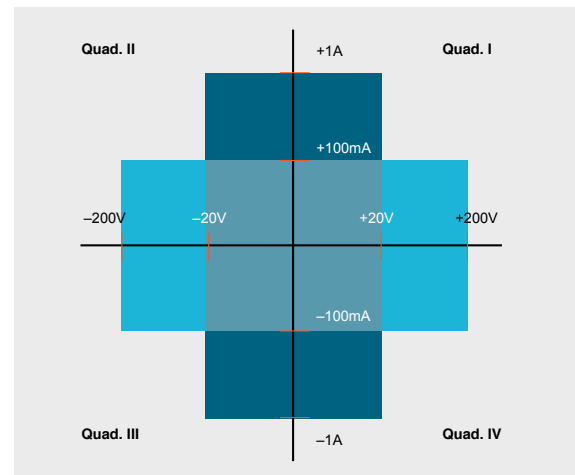


2450 icon-based menu.

Fourth-Generation, All-in-One SMU Instrument

The 2450 is the fourth-generation member of Keithley's award-winning SourceMeter family of SMU instruments and leverages the proven capabilities of the 2400 SourceMeter SMU Instrument. It offers a highly flexible, four-quadrant voltage and current source/load coupled with precision voltage and current meters. This all-in-one instrument gives you the capabilities of a:

- Precision power supply with V and I readback
- True current source
- Digital multimeter (DCV, DCI, ohms, and power with 6½-digit resolution)
- Precision electronic load
- Trigger controller



2450 power envelope.

Comparison Table: 2400 vs 2450

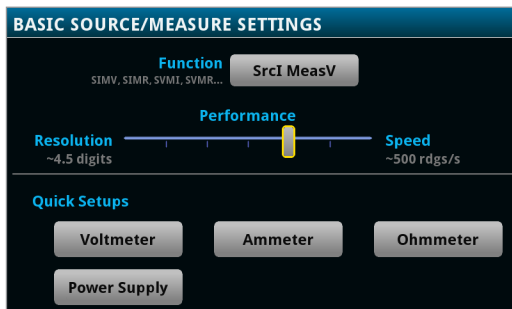
Model 2400	Model 2450
V-Ranges: 200 mV – 200 V	V-Ranges: 20 mV – 200 V
I-Ranges: 1 μ A – 1 A	I-Ranges: 10 nA – 1 A
0.012% Basic Accuracy	0.012% Basic Accuracy
Wideband Noise: 4 mV _{rms} Typ.	Wideband Noise: 2 mV _{rms} Typ.
Sweep Types: Linear, Log, Custom, Source-Memory	Sweep Types: Linear, Log, Dual Linear, Dual Log, Custom, Source-Memory (SCPI 2400 Mode)
5000 Point Reading Buffer	>250,000 Point Reading Buffer
>2000 Readings/Second	>3000 Readings/Second
SCPI Programming	SCPI (2400 + 2450) + TSP Programming
GPIB	GPIB, USB, Ethernet (LXI)
Front/Rear Banana Jacks	Front: Banana Jacks, Rear: Triax

Ease of Use Beyond the Touchscreen

In addition to its five-inch, color touchscreen, the 2450 front panel has many features that supplement its speed, user-friendliness, and learnability, including a USB 2.0 memory I/O port, a HELP key, a rotary navigation/control knob, a front/rear input selector button, and banana jacks for basic bench applications. The USB 2.0 memory port supports easy data storing, saving instrument configurations, loading test scripts, and system upgrades. Plus, all front panel buttons are backlit to enhance visibility in low-light environments.



2450 front panel with high-resolution, capacitive touchscreen.

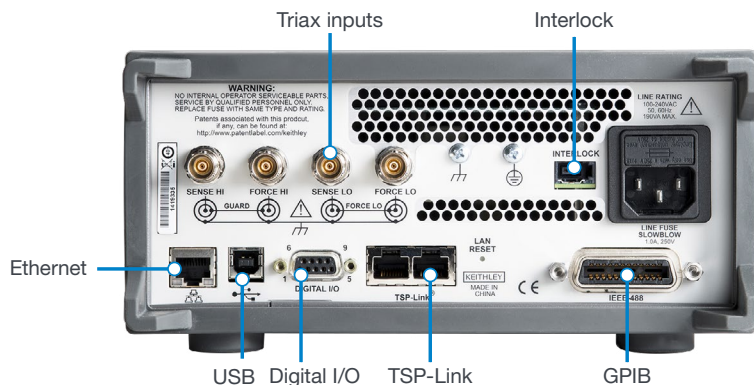


Four “Quickset” modes simplify user setup. With one touch, the instrument can be quickly configured for various operating modes without the need to configure the instrument indirectly for this operation.

Quickset modes enable fast setup and time to measurements.

Comprehensive Built-in Connectivity

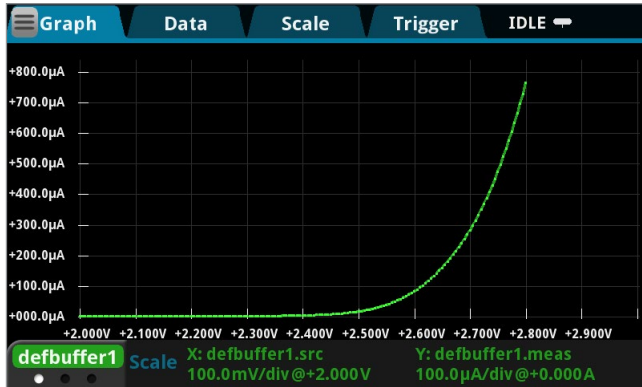
Rear panel access to rear-input triax connectors, remote control interfaces (GPIB, USB 2.0, and LXI/Ethernet), D-sub 9-pin digital I/O port (for internal/external trigger signals and handler control), instrument interlock control, and TSP-Link® jacks enables easy configuration of multiple instrument test solutions and eliminates the need to invest in additional adapter accessories.



Rear panel connections are optimized for signal integrity.

Convert Raw Data to Information

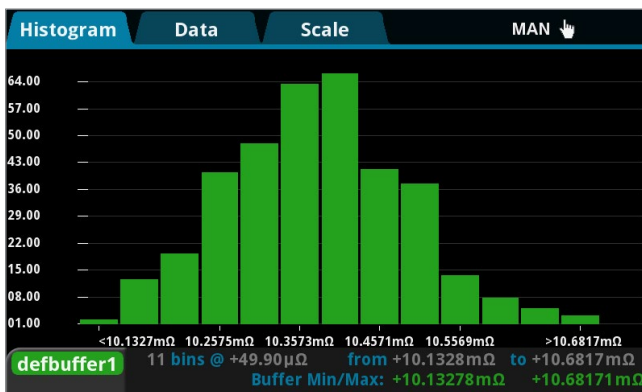
The 2450 provides a full plotting and sheet view to display sweeps, measurement data, and charting right on the screen. It also supports exporting to a spreadsheet for further analysis, dramatically improving productivity for research, bench-top testing, device qualification, and debugging.



READING TABLE

Buffer: Active (defbuffer1)

Index	Time	Reading	Source
62	11/14 11:30:49.891111	+0.08693 mA	+1.84858 V
63	11/14 11:30:49.962316	+0.08913 mA	+1.87886 V
64	11/14 11:30:50.033464	+0.09134 mA	+1.90919 V
65	11/14 11:30:50.104618	+0.09355 mA	+1.93952 V
66	11/14 11:30:50.175782	+0.09576 mA	+1.96982 V
67	11/14 11:30:50.246938	+0.09797 mA	+2.00013 V
68	11/14 11:30:50.318112	+0.10018 mA	+2.03042 V
69	11/14 11:30:50.389283	+0.10239 mA	+2.06071 V
70	11/14 11:30:50.460450	+0.10460 mA	+2.09100 V
71	11/14 11:30:50.531604	+0.10682 mA	+2.12133 V

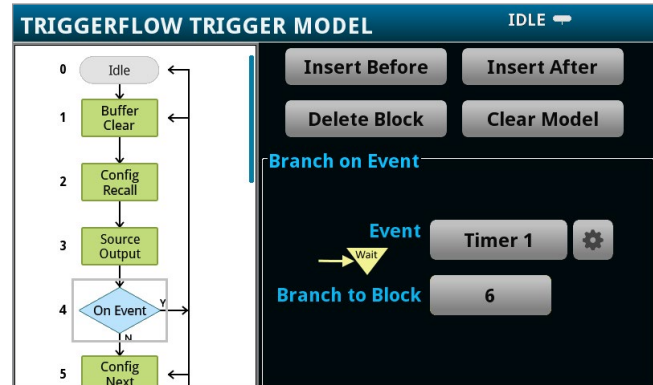


Full data display, charting, and export to a spreadsheet lets you convert raw data to useful information.

TriggerFlow® Building Blocks for Instrument Control and Execution

The 2450 incorporates Keithley's new TriggerFlow triggering system that allows user control of instrument execution. Similar to developing a flow chart, TriggerFlow diagrams are created using four fundamental building blocks:

- Wait – Waits for an event to occur before the flow continues
- Branch – Branches when a condition has been satisfied
- Action – Initiates an action in the instrument, for example, measure, source, delay, set digital I/O, etc.
- Notify – Notifies other equipment that an event has occurred



TriggerFlow building blocks let users create very simple to very complex triggering models.

A TriggerFlow model using a combination of these building blocks can be created from the front panel or by sending remote commands. With the TriggerFlow system, users can build triggering models from very simple to complex with up to 255 block levels. The 2450 also includes basic triggering functions, including immediate, timer, and manual triggering.

Unmatched System Integration and Programming Flexibility

When the 2450 is integrated as part of a multi-channel I-V test system, the Test Script Processor (TSP®) embedded scripting capability allows test scripts to be run by the instrument, enabling the user to create powerful measurement applications with significantly reduced development times. TSP technology also offers channel expansion without a mainframe. Keithley's TSP-Link® channel expansion bus, which uses a 100 Base T Ethernet cable, connects multiple 2450 instruments and other TSP instruments such as Keithley's Series 2600B SourceMeter SMU instruments and Series 3700A Switch/Multimeter systems in a master-slave configuration that behaves as one integrated system. The TSP-Link expansion bus supports up to 32 units per GPIB or IP address, making it easy to scale a system to fit an application's particular requirements.

The 2450 also includes a SCPI programming mode that optimizes the instrument's new features, as well as a SCPI 2400 mode that provides backwards compatibility with the existing 2400 SourceMeter instrument. Not only does this preserve your 2400 investment but it also eliminates re-work normally associated with upgrading to a new instrument with new capabilities.

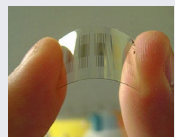
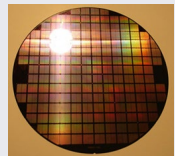
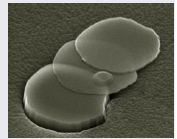
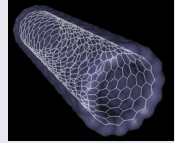
Parallel Test Capability

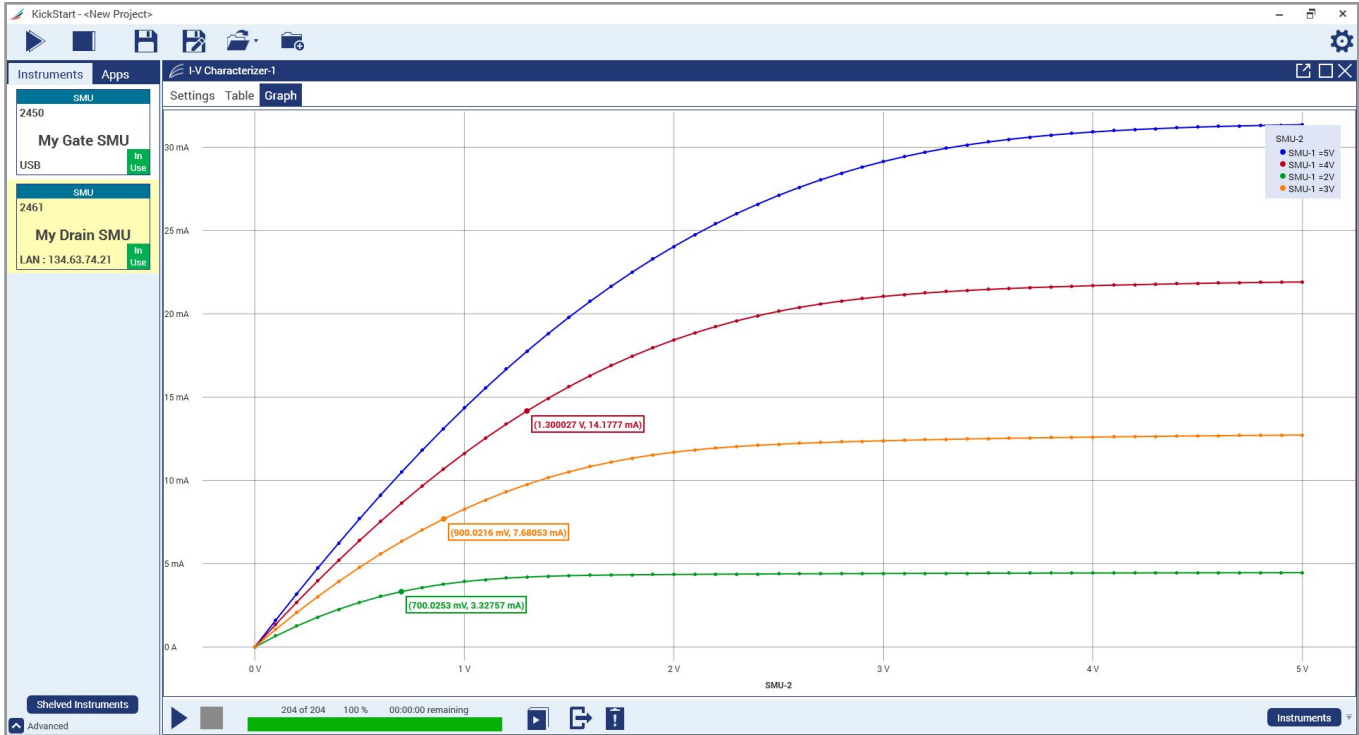
With the TSP technology in the 2450, multiple devices can be tested in parallel to meet the needs of device research, advanced semiconductor lab applications, and even high throughput production test. This parallel testing capability enables each instrument in the system to run its own complete test sequence, creating a fully multi-threaded test environment. The number of tests that can be run in parallel on a 2450 can be as high as the number of instruments in the system.

Typical Applications

Ideal for current/voltage characterization and functional test of a wide range of today's modern electronics and devices, including:

- Nanomaterials and Devices
 - Graphene
 - Carbon nanotubes
 - Nanowires
 - Low power nanostructures
- Semiconductor Structures
 - Wafers
 - Thin films
- Organic Materials and Devices
 - E-inks
 - Printable electronics
- Energy Efficiency and Lighting
 - LEDs/AMOLEDs
 - Photovoltaics/Solar cells
 - Batteries
- Discrete and Passive Components
 - Two-leaded: Resistors, diodes, zener diodes, LEDs, disk drive heads, sensors
 - Three-leaded: Small signal bipolar junction transistors (BJTs), field effect transistors (FETs), and more
- Material Characterization
 - Resistivity
 - Hall Effect
 - High ohmic resistance (using triax connectors)
- Electrochemistry
 - Cyclic voltammetry
 - Battery charge/discharge cycling
 - Electro-deposition





KickStart start-up software lets users be ready to make measurements in minutes.

Instrument Control Start-up Software

KickStart instrument control/start-up software enables users to start making measurements in minutes without programming. In most cases, users merely need to make some quick measurements, graph the data, and store the data to disk for later analysis in software environments such as Excel. KickStart offers:

- Instrument configuration control to perform I-V characterization
- Native X-Y graphing, panning, and zooming
- Spreadsheet/tabular viewing of data
- Saving and exporting of data for further analysis
- Saving of test setups
- Screenshot capturing of graphs
- Annotating of tests
- GPIB, USB 2.0, Ethernet compliance

Optional Apps Tailored for your Characterization Needs

The 2450 is an excellent tool to define nearly any DC test you choose for characterizing materials, electronic devices and modules. For more specific needs, Keithley offers on-instrument software apps that alter the 2450's behavior, fitting your instrument to your needs. These apps can be installed directly to your 2450 by connecting to Keithley's KickStart instrument control software and opening the relevant app in KickStart.

I-V Tracer App

Curve tracing analysis is a critical task for many users in the semiconductor development supply chain. Engineers and technicians both hold the traditional curve tracer as the simplest, fastest method for generating characteristic I-V curves on a device. They are heavily used by engineers in failure analysis and incoming inspection to qualify parts, identify counterfeit devices, and to quickly identify the location of a failure on damaged devices. SMUs have typically been limited to predefined sweeps with longer set up times than curve tracers — until I-V Tracer.

Keithley's I-V Tracer app leverages the touchscreen and front-panel knob of the 2450 to allow precise, live control over the SMU output while viewing I-V results of 2 terminal

devices. At each individual output level current and voltage are measured and plotted. The small footprint of the SMU enables portable bench top use, reserving high power (kW) traditional curve tracers for special cases. The power envelope of the 2450 allows it to comfortably operate in the low power range of traditional curve tracers like the Tektronix 576 and Tektronix 370A, while offering enhanced low current measurements.



I-V Tracer home screen

Once installed, I-V Tracer exists on the SMU itself, meaning I-V tracer can be used wherever your SMU can go, without a continuous remote connection. It can also integrate with KickStart to enable simple data collection and comparison on the PC, simplifying the preparation of reports used in failure analysis or teaching labs at colleges and universities.

I-V Tracer capabilities with the 2450:

- Use the full power envelope of the 2450 (max 200 V or 1 A)
- Trace by sourcing voltage or current, positive or negative
- 2 or 4-wire sense
- Compare mode for verifying against a reference device
- Reading table view to see exact measurements
- Easily copy curves and settings to your PC with KickStart

Simplified Programming with Ready-to-Use Instrument Drivers

For users who want to create their own customized application software, native National Instruments LabVIEW® drivers, IVI-C, and IVI-COM drivers are available at www.keithley.com.

Specifications

Voltage Specifications ^{1, 2}

Range	Source			Measure ³		
	Resolution	Accuracy (23° ± 5°C) 1 Year ±(% setting + volts)	Noise (RMS) (<10 Hz)	Resolution	Input Resistance	Accuracy (23° ± 5°C) 1 Year ±(% rdg. + volts)
20.00000 mV	500 nV	0.100% + 200 µV	1 µV	10 nV	>10 GΩ	0.100% + 150 µV
200.0000 mV	5 µV	0.015% + 200 µV	1 µV	100 nV	>10 GΩ	0.012% + 200 µV
2.000000 V	50 µV	0.020% + 300 µV	10 µV	1 µV	>10 GΩ	0.012% + 300 µV
20.00000 V	500 µV	0.015% + 2.4 mV	100 µV	10 µV	>10 GΩ	0.015% + 1 mV
200.0000 V	5 mV	0.015% + 24 mV	1 mV	100 µV	>10 GΩ	0.015% + 10 mV

Current Specifications ^{1, 2}

Range	Source			Measure ³		
	Resolution	Accuracy (23° ± 5°C) ⁴ 1 Year ±(% setting + amps)	Noise (RMS) (<10 Hz)	Resolution	Voltage Burden	Accuracy (23° ± 5°C) 1 Year ±(% rdg. + amps)
10.00000 nA ⁵	500 fA	0.100% + 100 pA	500 fA	10 fA	<100 µV	0.100% + 50 pA
100.0000 nA ⁵	5 pA	0.060% + 150 pA	500 fA	100 fA	<100 µV	0.060% + 100 pA
1.000000 µA	50 pA	0.025% + 400 pA	5 pA	1 pA	<100 µV	0.025% + 300 pA
10.00000 µA	500 pA	0.025% + 1.5 nA	40 pA	10 pA	<100 µV	0.025% + 700 pA
100.0000 µA	5 nA	0.020% + 15 nA	400 pA	100 pA	<100 µV	0.020% + 6 nA
1.000000 mA	50 nA	0.020% + 150 nA	5 nA	1 nA	<100 µV	0.020% + 60 nA
10.00000 mA	500 nA	0.020% + 1.5 µA	40 nA	10 nA	<100 µV	0.020% + 600 nA
100.0000 mA	5 µA	0.025% + 15 µA	100 nA	100 nA	<100 µV	0.025% + 6 µA
1.000000 A	50 µA	0.067% + 900 µA	3 µA	1 µA	<100 µV	0.030% + 500 µA

Temperature Coefficient (0°–18°C and 28°–50°C)

±(0.15 × accuracy specification)/°C.

Notes

- Speed = 1 PLC.
- All specifications are guaranteed with output ON.
- Accuracies apply to 2- and 4-wire mode when properly zeroed.
- For sink mode, 1 µA to 100 mA range accuracy is ±(0.15% + offset × 4). For 1A range, accuracy is ±(1.5% + offset × 8).
- Rear panel triax connections only.

Resistance Measurement Accuracy (Local or Remote Sense) ^{1, 2}

Range	Default Resolution ³	Default Test Current	Normal Accuracy (23°C ±5°C) 1 Year, ±(% rdg. + ohms)	Enhanced Accuracy ⁴ (23°C ±5°C) 1 Year, ±(% rdg. + ohms)
<2.000000 Ω ⁵	1 μΩ	User defined	Source I _{ACC} + Meas. V _{ACC}	Meas. I _{ACC} + Meas. V _{ACC}
20.00000 Ω	10 μΩ	100 mA	0.098% + 0.003 Ω	0.073% + 0.001 Ω
200.0000 Ω	100 μΩ	10 mA	0.077% + 0.03 Ω	0.053% + 0.01 Ω
2.000000 kΩ	1 mΩ	1 mA	0.066% + 0.3 Ω	0.045% + 0.1 Ω
20.00000 kΩ	10 mΩ	100 μA	0.063% + 3 Ω	0.043% + 1 Ω
200.0000 kΩ	100 mΩ	10 μA	0.065% + 30 Ω	0.046% + 10 Ω
2.000000 MΩ	1 Ω	1 μA	0.110% + 300 Ω	0.049% + 100 Ω
20.00000 MΩ	10 Ω	1 μA	0.110% + 1 kΩ	0.052% + 500 Ω
200.0000 MΩ	100 Ω	100 nA	0.655% + 10 kΩ	0.349% + 5k Ω
>200.0000 MΩ ⁵	—	User defined	Source I _{ACC} + Meas. V _{ACC}	Meas. I _{ACC} + Meas. V _{ACC}

Temperature Coefficient
(0°–18°C and 28°–50°C) ±(0.15 × accuracy specification)/°C.

Source Current, Measure Resistance Mode Total uncertainty = I_{source} accuracy + V_{measure} accuracy (4-wire remote sense).

Source Voltage, Measure Resistance Mode Total uncertainty = V_{source} accuracy + I_{measure} accuracy (4-wire remote sense).

Guard Output Impedance 0.5 Ω (DC) in ohms mode.

Notes

- All specifications are guaranteed with output ON.
- Accuracies apply to 2- and 4-wire mode when properly zeroed.
- 6.5 digit measure resolution
- Source readback enabled. Offset compensation ON.
- Source Current, Measure Resistance or Source Voltage, Measure Resistance only. For best measurements, use rear panel triax connectors.

Operating Characteristics

Max. Output Power	20 W, four-quadrant source or sink operation.
Source Limits	Vsource: ±21 V (≤ 1 A range), ±210 V (≤ 100 mA range) Isource: ±1.05 A (≤ 20 V range), ±105 mA (≤ 200 V range).
Overrange	105% of range, source and measure.
Regulation	Voltage: Line: 0.01% of range. Load: 0.01% of range + 100 μV. Current: Line: 0.01% of range. Load: 0.01% of range + 100 pA.
Source Limits	Voltage Source Current Limit: Bipolar current limit set with single value. Min. 10% of range. Current Source Voltage Limit: Bipolar voltage limit set with single value. Min. 10% of range.
V-Limit / I-Limit Accuracy	Add 0.3% of setting and ±0.02% of reading to base specification.
Overshoot	Voltage Source: <0.1% typical (full scale step, resistive load, 20 V range, 10 mA I-Limit). Current Source: <0.1% typical (1 mA step, R _{Load} = 10 kΩ, 20 V range).
Range Change Overshoot	Overshoot into a fully resistive 100 kΩ load, 10 Hz to 20 MHz BW, adjacent ranges: 250 mV typical
Output Settling Time	Time required to reach 0.1% of final value, 20 V range, 100 mA I-Limit: <200 μs typical.
Maximum Slew Rate	0.2 V/μs, 200 V range, 100 mA limit into a 2 kΩ load (typical).
Over Voltage Protection	User selectable values, 5% tolerance. Factory default = none.
Voltage Source Noise	10 Hz–1 MHz (RMS): 2 mV typical into a resistive load.
Common Mode Voltage	250 V DC.

Common Mode Isolation >1 GΩ, <1000 pF.

Noise Rejection (typical)

NPLC	NMRR	CMRR
0.01	—	60 dB
0.1	—	60 dB
1	60 dB	100 dB*

* Except lowest two current ranges -90dB.

Load Impedance 20 nF typical (standard). Stable into 50 μF typical (High-C mode).
High-C mode valid for ≥100 μA ranges, ≥200 mV ranges.

Max. Voltage Drop Between Force and Sense Terminals 5 V.

Max. Sense Lead Resistance 1 MΩ for rated accuracy.

Sense Input Impedance >10 GΩ.

Guard Offset Voltage <300 μV, typical

System Measurement Speeds ¹

Reading Rates (readings/second) typical for 60 Hz (50 Hz):

Script (TSP) Programmed

NPLC/Trigger Origin	Measure				Source-Measure Sweep			
	To Mem.	To GPIB	To USB	To LAN	To Mem.	To GPIB	To USB	To LAN
0.01 / Internal	3130 (2800)	2830 (2570)	2825 (2600)	2790 (2530)	1710 (1620)	1620 (1540)	1630 (1540)	1620 (1540)
0.01 / External	2170 (2050)	2150 (2030)	2170 (2040)	2160 (1990)	1670 (1590)	1580 (1500)	1590 (1510)	1580 (1510)
0.1 / Internal	540 (460)	530 (450)	530 (450)	530 (450)	470 (410)	460 (400)	470 (400)	470 (400)
0.1 / External	500 (430)	490 (420)	500 (430)	500 (420)	470 (400)	460 (390)	460 (400)	460 (400)
1.00 / Internal	59 (49)	58 (49)	59 (49)	59 (49)	58 (48)	58 (48)	58 (48)	58 (48)
1.00 / External	58 (48)	57 (48)	58 (48)	58 (48)	57 (48)	57 (47)	57 (48)	57 (48)

SCPI Programmed ²

NPLC/Trigger Origin	Measure				Source-Measure Sweep			
	To Mem.	To GPIB	To USB	To LAN	To Mem.	To GPIB	To USB	To LAN
0.01 / Internal	3130 (2800)	3060 (2760)	3000 (2790)	3010 (2710)	1710 (1630)	1610 (1600)	1440 (1380)	1690 (1590)
0.01 / External	2350 (2200)	2320 (2170)	2340 (2190)	2320 (2130)	1680 (1590)	1560 (1570)	1410 (1360)	1660 (1560)
0.1 / Internal	540 (460)	540 (450)	540 (460)	540 (450)	470 (410)	470 (410)	450 (390)	470 (410)
0.1 / External	510 (440)	510 (430)	510 (440)	510 (430)	470 (400)	470 (400)	450 (390)	470 (400)
1.00 / Internal	59 (49)	59 (49)	59 (49)	59 (49)	58 (48)	58 (48)	57 (48)	58 (48)
1.00 / External	58 (49)	58 (49)	58 (49)	58 (49)	58 (48)	58 (48)	57 (47)	58 (48)

Notes

1. Reading rates applicable for voltage or current measurements, autozero off, autorange off, filter off, binary reading format, and source readback off.
2. SCPI programming mode. Speeds do not apply to SCPI 2400 mode.

Supplied Accessories

8608	High Performance Test Leads
USB-B-1	USB Cable, Type A to Type B, 1 m (3.3 ft)
CS-1616-3	Safety Interlock Mating Connector
CA-180-3A	TSP-Link/Ethernet Cable
	Documentation CD
	2450 QuickStart Guide
	Test Script Builder Software (supplied on CD)
	KickStart Startup Software (supplied on CD)
	LabVIEW and IVI Drivers available at www.keithley.com

Available Accessories

Test Leads and Probes

1754	2-wire Universal 10-Piece Test Lead Kit
5804	Kelvin (4-Wire) Universal 10-Piece Test Lead Kit
5805	Kelvin (4-Wire) Spring-Loaded Probes
5806	Kelvin Clip Lead Set
5808	Low Cost Single-pin Kelvin Probe Set
5809	Low Cost Kelvin Clip Lead Set
8605	High Performance Modular Test Leads
8606	High Performance Modular Probe Kit
8608	High Performance Clip Lead Set

Cables, Connectors, Adapters

237-ALG-2	3-slot Male Triax Connector to 3 Alligator Clips
237-BAN-3A	Triax to Banana Plug
2450-TRX-BAN	Triax to Banana Adapter. Converts the 4 Triax adapters on the rear panel to 5 banana jacks
7078-TRX-*	3-slot, Low Noise Triax Cable
7078-TRX-GND	3-slot Male Triax To BNC Adapter (guard removed)
8607	2-wire, 1000V Banana Cables, 1 m (3.3 ft)
CA-18-1	Shielded Dual Banana Cable, 1.2 m (4 ft)
CAP-31	Protective Shield/Cap for 3-lug Triax Connectors
CS-1546	Triax 3-lug Special Shorting Plug. Shorts center pin to outer shield
CS-1616-3	Safety Interlock Mating Connector

Communication Interfaces and Cables

7007-1	Shielded GPIB Cable, 1 m (3.3 ft)
7007-2	Shielded GPIB Cable, 1 m (6.6 ft)
CA-180-3A	CAT5 Crossover Cable for TSP-Link/Ethernet
KPCI-488LPA	IEEE-488 Interface for PCI Bus
KUSB-488B	IEEE-488 USB-to-GPIB Interface Adapter
USB-B-1	USB Cable, Type A to Type B, 1 m (3.3 ft)

Triggering and Control

2450-TLINK	DB-9 to Trigger Link Connector Adapter.
8501-1	Trigger Link Cable, DIN-to-DIN, 1 m (3.3 ft)
8501-2	Trigger Link Cable, DIN-to-DIN, 2 m (6.6 ft)

Rack Mount Kits

4299-8	Single Fixed Rack Mount Kit
4299-9	Dual Fixed Rack Mount Kit
4299-10	Dual Fixed Rack Mount Kit. Mount one 2450 and one Series 26xxB
4299-11	Dual Fixed Rack Mount Kit. Mount one 2450 and one Series 2400, Series 2000, etc.

Test Fixtures

8101-PIV	DC Test Fixture
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Software Options

EC-UPGRADE	Upgrade 2450 SMU to 2450-EC Graphical Potentiostat
Kickstart	Instrument Control Software
ACS Basic Edition	Semiconductor Parametric Test Software for Component and Discrete Devices

Available Services

2450-3Y-EW	1 Year Factory Warranty extended to 3 years from date of shipment
2450-5Y-EW	1 Year Factory Warranty extended to 5 years from date of shipment
C/2450-3Y-17025	KeithleyCare® 3 Year ISO 17025 Calibration Plan
C/2450-3Y-DATA	KeithleyCare 3 Year Calibration w/Data Plan
C/2450-3Y-STD	KeithleyCare 3 Year Std. Calibration Plan
C/2450-5Y-17025	KeithleyCare 5 Year ISO 17025 Calibration Plan
C/2450-5Y-DATA	KeithleyCare 5 Year Calibration w/Data Plan
C/2450-5Y-STD	KeithleyCare 5 Year Std. Calibration Plan

General Characteristics (default mode unless specified)

Factory Default Standard Power-Up	SCPI Mode.
Source Output Modes	Fixed DC Level, Memory/Configuration List (mixed function), Stair (linear and log).
Source Memory List	100 points max. (SCPI 2400 Mode only).
Memory Buffer	>250,000 readings. Includes selected measured value(s) and time stamp.
Real-Time Clock	Lithium battery backup (3 yr. + battery life).
Remote Interfaces	
GPIOB	IEEE-488.1 compliant. Supports IEEE-488.2 common commands and status model topology.
USB Device (rear panel, type B)	2.0 Full Speed USBTMC.
USB Host (front panel, type A)	USB 2.0, support for flash drives, FAT32.
Ethernet	RJ-45 (10/100BT).
Digital I/O Interface:	
Lines	6 Input/Output user defined for digital I/O or triggering.
Connector	9-pin female D.
Input Signal Levels	0.7 V (maximum logic low), 3.7 V (minimum logic high).
Input Voltage Limits	-0.25 V (Abs. minimum), +5.25 V (Abs. maximum).
Maximum Source Current	+2.0 mA @ >2.7 V (per pin).
Maximum Sink Current	-50 mA @ 0.7 V (per pin, solid-state fuse protected).
5V Power Supply Pin	Limited to 500 mA @ >4 V (solid-state fuse protected).
Handler	User definable Start of Test, End of Test, 4 category bits.
Programmability	SCPI or TSP command sets.
TSP Mode	Embedded Test Script Processor (TSP) accessible from any host interface.
IP Configuration	Static or DHCP.
Expansion Interface	The TSP-Link expansion interface allows TSP enabled instruments to trigger and communicate with each other.
LXI Compliance	1.4 LXI Core 2011.
Display	5 inch capacitive touch, color TFT WVGA (800×480) with LED backlight.
Input Signal Connections	Front: Banana. Rear: Triaxial (3-lug).
Interlock	Active High Input.
Cooling	Forced air, variable speed.
Over Temperature Protection	Internally sensed temperature overload puts unit in standby mode.
Power Supply	100 V to 240 V RMS, 50–60 Hz (automatically detected at power up).
VA Rating	190 volt-amps max.
Altitude	Maximum 2000 meters above sea level.
EMC	Conforms to European Union EMC Directive.
Safety	NRTL listed to UL61010-1 and UL61010-2-30. Conforms with European Union Low Voltage Directive.
Vibration	MIL-PRF-28800F Class 3 Random.

Warm-Up	1 hour to rated accuracies.
Dimensions	With bumpers and handle: 106 mm high × 255 mm wide × 425 mm deep (4.18 in × 10.05 in × 16.75 in). Without bumpers and handle: 88 mm high × 213 mm wide × 403 mm deep (3.46 in × 8.39 in × 15.87 in.)
Weight	With bumpers and handle: 4.04 kg (8.9 lbs.). Without bumpers and handle: 3.58 kg (7.9 lbs.).
Environment	Operating: 0°–50 °C, 70% R.H. up to 35 °C. Derate 3% R.H./°C, 35°–50 °C. Storage: –25 °C to 65 °C.
Accessories Supplied	Test Leads, USB Cable, Ethernet/TSP Cable, Interlock Adapter, Power Cord, Quick Start Guide, CD User's Manual.

Ordering Information

2450	200 V, 1 A, 20 W SourceMeter Instrument
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Warranty Information

Warranty Summary	This section summarizes the warranties of the 2450. For complete warranty information, refer to the 2450 Reference Manual. Any portion of the product that is not manufactured by Keithley is not covered by this warranty and Keithley will have no duty to enforce any other manufacturer's warranties.
Hardware Warranty	Keithley Instruments, Inc. warrants the Keithley manufactured portion of the hardware for a period of one year from defects in materials or workmanship; provided that such defect has not been caused by use of the Keithley hardware which is not in accordance with the hardware instructions. The warranty does not apply upon any modification of Keithley hardware made by the customer or operation of the hardware outside the environmental specifications.
Software Warranty	Keithley warrants for the Keithley produced portion of the software or firmware will conform in all material respects with the published specifications for a period of ninety (90) days; provided the software is used on the product for which it is intended in accordance with the software instructions. Keithley does not warrant that operation of the software will be uninterrupted or error-free, or that the software will be adequate for the customer's intended application. The warranty does not apply upon any modification of the software made by the customer.



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